NOTES:

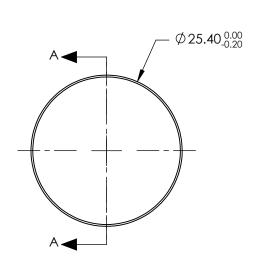
- SUBSTRATE: FUSED SILICA
- 2. COATING (APPLY ACROSS CLEAR APERTURE)

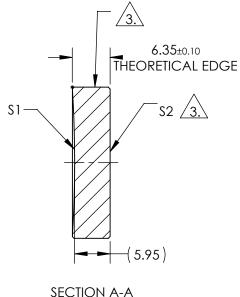
S1: Ultrafast-Enhanced Silver R(AVG) >99% @ 850-1150nm @ 0° AOI Rs >99% @ 800-1150nm @ 45° AOI Rp >98.5% @ 850-1100nm @ 45° AOI GDD: 0 ±30 fs² @ 800 - 1150 nm

S2: NONE



- 4. EFL (EFFECTIVE FOCAL LENGTH): 100mm
- 5. Damage Threshold, Pulsed: 0.4 J/cm2 @ 1030nm, 200fs, 1 pulse (typical) 0.18 J/cm2 @ 1030nm, 200fs, 100Hz, 1000 pulses (typical)





FOR INFORMATION ONLY: PARTS TO THIS DRAWING

SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

	\$1	\$2			
SHAPE	CONCAVE	PLANO			
RADIUS	200.00	INFINITY			
SURFACE QUALITY	20-10	N/A		1	
CLEAR APERTURE	22.86mm	N/A	THIRD ANGLE PROJECTION	\bigcirc	TITLE
IRREGULARITY AT 632.8nm	λ/10	N/A		1	
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO

			Edmund Optics ®		
THIRD ANGLE PROJECTION	$\phi \Box$	TITLE	800-1150nm, 25.4mm Dia. x 100mm Ultrafast-Enhanced Silver Concave M		
ALL DIMS IN	mm	DWG NO	17270	SHEET 1 OF 1	